The ISL8115 is a synchronous buck PWM controller with current sharing capability. The current sharing function allows multiple modules to be connected in parallel to achieve higher output current and to reduce input and output ripple current, resulting in fewer components and reduced output dissipation.

Utilizing voltage-mode control with input voltage feed-forward compensation, the ISL8115 maintains a constant loop gain for optimal transient response, especially for applications with a wide input voltage range.

The ISL8115 protects against overcurrent conditions by inhibiting the PWM operation while monitoring the current with DCR of the output inductor, or a precision resistor. It also has a pre-POR overvoltage protection option, which provides some protection to the load if the upper MOSFET(s) is shorted.
The ISL8115 features remote ground sensing, programmable input voltage UVLO, output under/overvoltage protection, power-good indication, and fault Hand Shake capability.

## Applications

- Power supply for datacom/telecom and POL
- Wide input voltage range buck regulators
- High current density power supplies RF power amplifier bias compensation


## Features

- Wide $\mathrm{V}_{\mathrm{IN}}$ range operation: 2.97 V to 36 V ; up to 5.5 V output and 30A load current per phase
- Fast transient response
- Voltage-mode PWM leading-edge modulation with non-linear control
- Input voltage feed-forward
- Integrated 5V high speed 4A MOSFET gate drivers
- Internal bootstrap diode
- Excellent output voltage regulation
- $0.6 \mathrm{~V} \pm 1.0 \%$ internal reference $\left(-40^{\circ} \mathrm{C} \sim 125^{\circ} \mathrm{C}\right)$
- $0.6 \mathrm{~V} \pm 0.7 \%$ internal reference $\left(-40^{\circ} \mathrm{C} \sim 105^{\circ} \mathrm{C}\right)$
- Differential voltage sensing
- Excellent current balancing and overcurrent protection
- Peak and average overcurrent protection
- Output current monitor on the ISET pin
- Oscillator programmable from 150 kHz to 1.5 MHz
- Frequency synchronization to external clock signal
- Diode emulation mode for light load efficiency improvement
- Power-good open drain output
- Pre-bias start-up function
- Output OVP, UVP; OTP
- Adjustable Soft-Start


FIGURE 1. TYPICAL APPLICATION CIRCUIT, 10V-15V INPUT, 1.5V/30A OUTPUT

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## Application Diagrams



FIGURE 2. TYPICAL APPLICATION CIRCUIT, 24V-36V INPUT, 5V/20A OUTPUT

## Application Diagrams (contruaos)



FIGURE 3. 2-PHASE, $10 \mathrm{~V}-15 \mathrm{~V}$ INPUT, $1.5 \mathrm{~V} / 60 \mathrm{~A}$ OUTPUT

## Block Diagram



## Pin Configuration



## Functional Pin Descriptions

| PIN NUMBER | SYMBOL | DESCRIPTION |
| :---: | :---: | :---: |
| 1 | FSET | Placing a resistor ( $\mathrm{R}_{\text {FSET }}$ ) from this pin to GND to adjust the switching frequency. Input an external clock signal to this pin and the internal oscillator synchronizes with the leading edge of the input signal. |
| 2 | EN | The input voltage to this pin is compared with a precision 1.22 V reference. Tie this pin to ground to disable the part. Tie this pin to VIN through a resistor divider to realize undervoltage lock-out. |
| 3 | Vcc | This pin provides power for the analog circuitry. Connect this pin to a 2.97 V to 5.15 V bias through a recommended RC filter. This pin can be powered up by the internal or external linear regulator. A $2.2 \mu \mathrm{~F}$ filter capacitor is recommended to connect closely to the pin. |
| 4 | PGOOD | Provides an open drain Power-Good signal when the voltage at VMON is within $\pm 10 \%$ of nominal output regulation point after soft-start is complete. |
| 5 | RAMP | A resistor to GND to set the sawtooth ramp. Select the resistor value to make the ramp amplitude the same as the voltage on VFF. Refer to Voltage Feedforward Section on Page 15. $R_{\text {ramp }}=\frac{T_{s}-275 n s}{3 \times 10 p F} ; T s=\frac{1}{F_{S W}}$ |
| 6 | VFF | Pin for input voltage feed-forward. The voltage at this pin sets the internal oscillator ramp peak-to-peak amplitude at $1 \times \mathrm{XVFF}$. A resistor divider network from input voltage to this pin is required and an additional decoupling capacitor may be required at this pin in noisy input environments. Make sure VFF is in the range of the clamp voltage ( 0.53 V to 2.59 V ) specified in "Electrical Specifications" on page 9. |
| 7 | VIN | This pin should be tied directly to the input rail when using the internal linear regulator. It provides power to the internal linear drive circuitry. |
| 8 | B00T | This pin provides the bootstrap bias for the high-side driver. |
| 9 | UGATE | This pin provides the drive signals for the high-side devices and should be connected to the high-side MOSFETs' gates. |
| 10 | PHASE | Connect this pin to the source of the high-side MOSFETs and the drain of the low-side MOSFETs. This pin represents the return path for the high-side gate drivers. |
| 11 | PVCC | Connect a $4.7 \mu \mathrm{~F}$ capacitor closely to this pin. This pin is the output of the internal series linear regulator. It provides the bias for both low-side and high-side drivers. Its operational voltage range is 2.97 V to 5.3 V . When the input supply is $\leq 5 \mathrm{~V}$, this pin should be tied directly to VIN to eliminate the dropout voltage in the internal linear regulator. |

## Functional Pin Descriptions (continuod)

| PIN NUMBER | SYMBOL | DESCRIPTION |
| :---: | :---: | :---: |
| 12 | LGATE | This pin provides the drive for the low-side devices and should be connected to the lower MOSFETs' gates. |
| 13 | ISENA | The positive input of the current sensing amplifier. Provide DCR, or precision resistor current sensing. |
| 14 | ISENB | The negative input of the current sensing amplifier. Provide DCR, or precision resistor current sensing. |
| 15 | VMON | This pin monitors the regulator's output for OV and UV protection. PGOOD refers to the voltage on VMON. Connect a resistor divider from VOUT to RGND, with the same ratio as the FB resistor divider. It is not recommended to share the resistor divider for both FB and VMON; the response to a fault may not be as quick or robust. The voltage on this pin is also monitored for the non-linear control. |
| 16 | RGND | Pin for remote ground sensing. There's a current sourcing out from RGND if ISET voltage is lower than ISHARE in the multi-phase configuration. A typical $100 \Omega$ resistor is required connected between RGND and negative terminal of the load. |
| 17 | FB | FB is the inverting input of the error amplifier. This pin is connected to the feedback resistor divider and provides the voltage feedback signal for the controller. |
| 18 | COMP | This pin is the error amplifier's output. It should be connected to the FB pin through a desired compensation network. The lower limit of the voltage at COMP is 0.85 V . |
| 19 | ISET | This pin sources a current equal to 5 times $I_{\text {SEN }}$ with $50 \mu \mathrm{~A}$ offset. Connect $\mathrm{R}_{\text {ISET }}$ to the pin to adjust the OCP trigger point. ParalleI $C_{\text {ISET }}$ with $R_{\text {ISET }}$ to obtain the average output current signal at this pin. The voltage $V_{\text {ISET }}$ set by an external resistor R $_{\text {ISET }}$ represents the sensed current for the controller which compares with the internal reference to implement over current protection. Refer to the ""Average Overcurrent Protection" on page 18. |
| 20 | ISHARE | This pin is used for current sharing purpose and is configured to the current share bus representing all module's reference current. The voItage $V_{\text {ISHARE }}$ represents the highest voltage of $V_{\text {ISET }}$ of all active ISL8115(s) that connected together to the current share bus. Float in single phase operation. Pulling this pin low will disable the ISL8115. |
| 21 | PLL_COMP | Compensation pin for the internal PLL circuit. A compensation network shows in the typical application diagram is required. $\mathrm{R}_{\mathrm{PLL}}(5.11 \mathrm{k} \Omega)$; $\mathrm{C}_{\text {PLL }}(2.2 \mathrm{nF})$; $\mathrm{C}_{\mathrm{PLL}} \mathrm{H}(390 \mathrm{pF})$ are recommended. |
| 22 | CONF | A resistor at this pin is used to set: 1.) Enable or disable Diode emulation mode, and 2) Phase delay of clock out signal with respect to input clock signal. See Table 1 for the resistor values. |
| 23 | CLKOUT | This pin provides clock signal to synchronize with other ISL8115(s). The phase delay of the CLKOUT with respect to the external clock signal is configured through CONF pin. |
| 24 | SS | A resistor connected from this pin to ground is used to select the length of soft-start period. See Table 2 for the resistor values. |
| 25 | GND | All voltage levels are referenced to this pad. This pad provides a return path for the low side MOSFET drivers and internal power circuitries as well as analog signals. Connect this pad to the board ground with the shortest possible path ( 9 vias to the internal ground plane, placed on the soldering pad are recommended). |

## Ordering Information

| PART NUMBER (Notes 1, 2, 3) | PART MARKING | TEMP RANGE $\left({ }^{\circ} \mathrm{C}\right)$ | PACKAGE <br> (Pb-free) | PKG. DWG. \# |
| :---: | :---: | :---: | :---: | :---: |
| ISL8115FRTZ | 81 15FRTZ | -40 to +125 | 24 Ld Exposed Pad 4x4 TQFN | L24.4x4F |
| ISL8115EVAL1Z | 12 V to 1.5V/30A Evaluation Board |  |  |  |
| ISL8115EVAL2Z | 28 V to 5V/20A Evaluation Board |  |  |  |

## NOTES:

1. Add " $-T *$ " suffix for tape and reel. Please refer to $\overline{T B 347}$ for details on reel specifications.
2. These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and $100 \%$ matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb -free soldering operations). Intersil Pb free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.
3. For Moisture Sensitivity Level (MSL), please see device information page for ISL8115. For more information on MSL please see techbrief TB363.

| Absolute Maximum Ratings |  |
| :---: | :---: |
| VIN | -0.3V to 38V |
| PVCC. | -0.3V to +6V |
| VCC | -0.3V to +6V |
| PVCC to VCC | . .-1V to +1V |
| BOOT | -0.3 V to +44V |
| PHASE | -0.3V to +41V |
| PHASE Voltage Transient (20ns max) | . . GND - 2 V |
| Boot to Phase Voltage, BOOT-PHASE. | -0.3V to +6V |
| LGATE. | . -0.3 V to +6 V |
| LGATE Voltage Transient (20ns max) | GND -2.6V |
| ISENA, ISENB. | -0.3V to +6.675V |
| Voltage on All Other Pins. | -0.3 V to $\mathrm{V}_{\mathrm{CC}}+0.3 \mathrm{~V}$ |
| ESD Rating |  |
| Human Body Model (Tested per JESD22-A114E). | . 2.5 kV |
| Machine Model (Tested per JESD22-A115-A). | . 250 V |
| Latch Up (Tested per JESD-78B; Class 1, Level A) | 100mA |

## Thermal Information

| Thermal Resistance (Typical) | $\theta_{\mathrm{JA}}\left({ }^{\circ} \mathbf{C} / \mathrm{W}\right)$ | $\theta_{\text {JC }}\left({ }^{\circ} \mathrm{C} / \mathrm{W}\right)$ |
| :---: | :---: | :---: |
| 24 Ld QFN Package (Note 5). . | 39 | 3.5 |
| Maximum Junction Temperature | kage) | + $150^{\circ} \mathrm{C}$ |
| Storage Temperature Range. |  | $5^{\circ} \mathrm{C}$ to $+150^{\circ} \mathrm{C}$ |
| Pb-Free Reflow Profile . . . . . . . . . http://www.intersil.com/pbfre | ow.asp | see link below |

## Recommended Operating Conditions

| mperature | ${ }^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ |
| :---: | :---: |
| Input Voltage, $\mathrm{V}_{\text {IN }}$ | 2.97 V to 36V |
| Driver Bias Voltage, PVCC | 2.97 V to 5.5V |
| Signal Bias Voltage, VCC . | 2.97V to 5.5V |
| Boot-to-Phase Voltage (Ov | <6V |

CAUTION: Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

NOTES:
4. Unless otherwise specified, voltages are from the indicated pins to GND
5. $\theta_{\mathrm{JA}}$ is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.
6. For $\theta_{\mathrm{Jc}}$, the "case temp" location is the center of the exposed metal pad on the package underside.

Electrical Specifications Recommended Operating Conditions $\mathrm{V}_{\mathrm{IN}}=12 \mathrm{~V}$; $\mathrm{V}_{\mathrm{CC}}=\mathrm{PVCC}=5.15 \mathrm{~V}$; $\mathrm{F}_{\mathrm{SW}}=500 \mathrm{kHz}$;
$\mathrm{EN}=\mathrm{High})$, Unless Otherwise Noted. Boldface limits apply over the operating temperature range, $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$.

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN (Note 7) | TYP | MAX <br> (Note 7) | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| POWER SUPPLY |  |  |  |  |  |  |
| $\mathrm{I}_{\text {Q_VIN }}$ | Nominal Supply VIN Current | UGATE $=$ LGATE $=0$ Oen |  | 10 | 15 | mA |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{IN}}=3.3 \mathrm{~V} ; \mathrm{V}_{\mathrm{CC}}=\mathrm{PVCC} ; \\ & \text { UGATE }=\mathrm{LGATE}=\text { Open } \end{aligned}$ |  | 10 | 15 | mA |
| IQ_VIN_disable | Disable Supply VIN Current | $\mathrm{EN}=0 \mathrm{~V}, \mathrm{~V}_{\text {IN }}=24 \mathrm{~V}$ |  | 17 | 25 | $\mu \mathrm{A}$ |
| IPVCC_disable | PVCC Shutdown Current (sinking) | $\mathrm{EN}=0 \mathrm{~V}, \mathrm{PVCC}=\mathrm{V}_{\mathrm{IN}}=5.2 \mathrm{~V}$ |  |  | 1.0 | $\mu \mathrm{A}$ |
| IVCC_disable | VCC Shutdown Current (sinking) | $\mathrm{EN}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{CC}}=\mathrm{V}_{\mathrm{IN}}=5.2 \mathrm{~V}$ |  |  | 1.0 | $\mu \mathrm{A}$ |
| INTERNAL LINEAR REGULATOR |  |  |  |  |  |  |
| PVCC | PVCC Voltage Level | $\mathrm{I}_{\text {PVCC }}=0 \mathrm{~mA}$ to 50 mA | 5.0 | 5.15 | 5.3 | V |
| IPVCC_LIMIT | Output Current Limit | $\mathrm{V}_{\mathrm{CC}}=\mathrm{PVCC}=3 \mathrm{~V} ; \mathrm{V}_{\mathrm{IN}}=5.4 \mathrm{~V}$ | 85 | 140 |  | mA |
| $\mathrm{R}_{\text {LIN }}$ | Saturated Equivalent Impedance | P-Channel MOSFET; $\mathrm{V}_{\mathrm{IN}}=5 \mathrm{~V}$ |  | 7 |  | $\Omega$ |
| POWER-ON RESET |  |  |  |  |  |  |
|  | Rising VCC Threshold |  |  | 2.88 | 2.95 | V |
|  | VCC POR Hysteresis |  |  | 170 |  | mV |
|  | Rising PVCC Threshold |  |  | 2.88 | 2.95 | V |
|  | PVCC POR Hysteresis |  |  | 170 |  | mV |
| ENABLE |  |  |  |  |  |  |
|  | Turn-On Threshold Voltage |  | 1.12 | 1.22 | 1.32 | V |
| IEN_HYS | Enable Hysteresis |  |  | 65 |  | mV |
| OSCILLATOR |  |  |  |  |  |  |
|  | Oscillator Frequency Range |  | 150 |  | 1500 | kHz |
|  | Oscillator Frequency | $\mathrm{R}_{\mathrm{FSET}}=165 \mathrm{k} \Omega$ | 135 | 150 | 165 | kHz |

Electrical Specifications Recommended Operating Conditions ( $\mathrm{V}_{\mathrm{IN}}=12 \mathrm{~V} ; \mathrm{V}_{\mathrm{CC}}=\mathrm{PVCC}=5.15 \mathrm{~V}$; $\mathrm{F}_{\mathrm{SW}}=500 \mathrm{kHz}$;
$\mathrm{EN}=\mathrm{High})$, Unless Otherwise Noted. Boldface limits apply over the operating temperature range, $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$. (Continued)

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN (Note 7) | TYP | $\begin{aligned} & \text { MAX } \\ & \text { (Note 7) } \end{aligned}$ | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | Oscillator Frequency | $\mathrm{R}_{\text {FSET }}=47.8 \mathrm{k} \Omega$ | 450 | 500 | 550 | kHz |
|  | Oscillator Frequency | $\mathrm{R}_{\text {FSET }}=14.54 \mathrm{k} \Omega$ | 1350 | 1500 | 1650 | kHz |
|  | Oscillator Frequency Total Variation | $\mathrm{VCC}=5.15 \mathrm{~V}$, From 150 kHz to 1500 kHz | -10 |  | +10 | \% |
|  | Frequency Synchronization Range |  | 150 |  | 1500 | kHz |
|  | Input Signal Duty Cycle | Apply a input clock signal on FSET pin | 10 |  | 90 | \% |
| CLKOUT $_{\text {H }}$ | Clock Output High | $\mathrm{I}=500 \mu \mathrm{~A}$ (sourcing) | 4.9 |  |  | V |
| CLKOUT $_{\text {L }}$ | Clock Output Low | $\mathrm{I}=500 \mu \mathrm{~A}$ (sinking) |  |  | 0.3 | v |
| CLKOUT $_{\text {tR }}$ | Clock Output Rise Time | $\mathrm{C}_{\text {LOAD }}=100 \mathrm{pF}$ |  | 27 |  | ns |
| CLKOUT $_{\text {tF }}$ | Clock Output Fall Time | $\mathrm{C}_{\text {LOAD }}=100 \mathrm{pF}$ |  | 27 |  | ns |
| SAWTOOTH RAMP |  |  |  |  |  |  |
| $\mathrm{V}_{\text {SRAMP_offset }}$ | Sawtooth Ramp Offset | $\mathrm{R}_{\text {RAMP }}=(\mathrm{Ts}-275 \mathrm{n}) / 30 \mathrm{p}$ |  | 1 |  | v |
| $V_{\text {SRAMP_Max }}$ | Sawtooth Ramp Peak Clamp Value |  |  | $\mathrm{V}_{\mathrm{Cc}}-1.2 \mathrm{~V}$ |  | v |
| $\mathrm{G}_{\text {SRAMP }}$ | Linear Gain of Sawtooth Ramp Over $V_{F F}$ | $\begin{aligned} & \mathrm{G}_{\text {RAMP }}=\mathrm{DV} \mathrm{VAMP}_{\text {RAM }} \mathrm{PK}-\mathrm{PK} / \mathrm{V}_{\mathrm{FF}} \\ & \mathrm{R}_{\text {RAMP }}=(\mathrm{Ts}-275 \mathrm{n}) / 30 \mathrm{p} \end{aligned}$ |  | 1 |  | v/V |
| $\mathrm{V}_{\text {SRAMP_pk-pk }}$ | Sawtooth Ramp Peak-to-Peak Voltage | $\mathrm{V}_{\mathrm{CC}}=5.15 \mathrm{~V} ; \mathrm{VFF}=1 \mathrm{~V}$ |  | 1 |  | v |
| $\mathrm{V}_{\text {RAMP_max }}$ | Upper Clamp Voltage of RAMP PIN |  | 2.59 | 2.98 | 3.36 | v |
| $\mathrm{V}_{\text {RAMP_min }}$ | Lower Clamp Voltage of RAMP PIN |  | 0.48 | 0.5 | 0.53 | v |

## PWM

|  | Minimum LGATE On-TIME |  | 150 | 200 | 250 | ns |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| REFERENCE ACCURACY |  |  |  |  |  |  |
| $\mathrm{V}_{\mathrm{FB}}$ | Voltage on FB |  |  | 0.6 |  | V |
|  | Accuracy | From $-40^{\circ} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$ | -1.0 |  | +1.0 | \% |
|  | Accuracy | From $-40^{\circ} \mathrm{C}$ to $+105^{\circ} \mathrm{C}$ | -0.7 |  | +0.7 | \% |

## ERROR AMPLIFIER

|  | DC Gain | $\mathrm{R}_{\mathrm{L}}=10 \mathrm{k}, \mathrm{C}_{\mathrm{L}}=1 \mathrm{pF}$ at COMP pin | 98 | dB |
| :---: | :---: | :---: | :---: | :---: |
| UGBW | Unity Gain-Bandwidth | $\mathrm{R}_{\mathrm{L}}=10 \mathrm{k}, \mathrm{C}_{\mathrm{L}}=1 \mathrm{pF}$ at COMP pin | 25 | MHz |
|  | Output Minimum Voltage Swing |  | 0.85 | V |
|  | Output Maximum Voltage Swing |  | $\mathrm{V}_{\mathrm{CC}}-0.8$ | V |
| SR_EA | Output Slew Rate | $\mathrm{R}_{\mathrm{L}}=10 \mathrm{k}, \mathrm{C}_{\mathrm{L}}=1 \mathrm{pF}$ at COMP pin | $\pm 20$ | $\mathrm{V} / \mu \mathrm{s}$ |
| $\mathrm{I}_{\mathrm{FB}}$ | FB Input Current |  | 20 | nA |
| $\mathrm{I}_{\text {COMP }}$ | Output Source/Sink Current |  | $\pm 3$ | mA |
|  | Effective RGND Range | With respect to GND | $\pm 200$ | mV |
| GATE DRIVER |  |  |  |  |
| RUGATE_SOURCE | Upper Drive Source Resistance | 45mA Source Current | 1.2 | $\Omega$ |
| RUGATE_SINK | Upper Drive Sink Resistance | 45mA Sink Current | 0.55 | $\Omega$ |
| RLGATE_SOURCE | Lower Drive Source Resistance | 45mA Source Current | 0.9 | $\Omega$ |
| RLGATE_SINK | Lower Drive Sink Resistance | 45mA Sink Current | 0.4 | $\Omega$ |
|  | UGATE to PHASE Internal Resistor |  | 10 | $\mathrm{k} \Omega$ |
|  | LGATE to GND Internal Resistor |  | 40 | k $\Omega$ |

Electrical Specifications Recommended Operating Conditions ( $\mathrm{V}_{\mathrm{IN}}=12 \mathrm{~V}$; $\mathrm{V}_{\mathrm{CC}}=\mathrm{PVCC}=5.15 \mathrm{~V}$; $\mathrm{F}_{\mathrm{SW}}=500 \mathrm{kHz}$; $\mathrm{EN}=\mathrm{High}$ ), Unless Otherwise Noted. Boldface limits apply over the operating temperature range, $-\mathbf{4 0 ^ { \circ }} \mathrm{C}$ to $+125^{\circ} \mathrm{C}$. (Continued)

| SYMBOL | PARAMETER | TEST CONDITIONS | MIN <br> (Note 7) | TYP | MAX <br> (Note 7) | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CURRENT SENSE AMPLIFIER |  |  |  |  |  |  |
|  | DC Gain |  |  | 70 |  | dB |
|  | Unity Gain-Bandwidth |  |  | 5 |  | MHz |
|  | ISENA Pin Input current |  |  | 10 |  | nA |
|  | Input Common Mode Range | $\mathrm{V}_{\mathrm{IN}}>9 \mathrm{~V}$ | -0.2 |  | 6.375 | V |
|  | Input offset |  | -0.6 |  | 0.6 | mV |
|  | Differential Current Sense Voltage Range | $\mathrm{R}_{\text {ISEN }}=2 \mathrm{k} \Omega$ | -8 |  | 40 | mV |
| ISET_OFFSET | ISET Offset Current |  | 44 | 50 | 55 | $\mu \mathrm{A}$ |
| IDEM_threshold | ISEN Threshold of DEM | $\mathrm{R}_{\text {ISEN }}=2 \mathrm{k} \Omega$ | 0.38 | 1.135 | 2.76 | $\mu \mathrm{A}$ |
| OVERCURRENT PROTECTION |  |  |  |  |  |  |
| $\mathrm{I}_{\mathrm{OC}}$ | ISEN Overcurrent Limit | $\mathrm{V}_{\mathrm{CC}}=5.15 \mathrm{~V}$ | 17.6 | 20 | 22.4 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{CC}}=2.97 \mathrm{~V}$ to 5.15 V |  | 20 |  | $\mu \mathrm{A}$ |
| VISET_OC | ISET Pin OC Threshold | $\mathrm{V}_{\mathrm{CC}}=2.97 \mathrm{~V}$ to 5.15 V |  | 1.40 |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=5.15 \mathrm{~V}$ | 1.35 | 1.40 | 1.45 | V |
|  | ISET Pin Under Current Threshold |  | 0.22 | 0.25 | 0.28 | V |
|  | ISHARE Pin Fault Threshold |  | 0.22 | 0.225 | 0.24 | V |
|  | ISHARE Pull-Down Voltage Capability | $I_{\text {SHARE }}=500 \mu \mathrm{~A}$ |  |  | 0.2 | V |
| POWER GOOD MONITOR AND UNDER/OVERVOLTAGE PROTECTION |  |  |  |  |  |  |
| $\mathrm{V}_{\text {PG- }}$ | Power-Good Lower Threshold | Voltage from VMON to RGND; ~3 clock cycles noise filter | 0.51 | 0.54 | 0.57 | V |
| $\mathrm{V}_{\mathrm{PG}+}$ | Power-Good Upper Threshold | Voltage from VMON to RGND; ~3 clock cycles noise filter | 0.63 | 0.66 | 0.69 | V |
|  | PGOOD Low Output Voltage | $\mathrm{IPGOOD}=2 \mathrm{~mA}$ |  |  | 0.35 | V |
| UNDER/OVER VOLTAGE PROTECTION WITH VMON |  |  |  |  |  |  |
| V ${ }_{\text {OV_NONLatch }}$ | Overvoltage Non-Latching Off Threshold | Voltage from VMON to RGND; above the Power-Good Upper Threshold |  | 30 |  | mV |
| $\mathrm{V}_{\text {OV_Latch }}$ | Overvoltage Latching Off Threshold | Voltage from VMON to RGND; above the OV Non-Latching UP Threshold |  | 30 |  | mV |
|  | Overvoltage LGATE Release Trip Point | Voltage from VMON to RGND |  | 0.51 |  | V |
| VUV | Undervoltage Protection Trip Point | Voltage from VMON to RGND; after soft-start completed |  | 0.3 |  | V |
| V ${ }_{\text {UV }}$ | Undervoltage Protection Trip Point Hysteresis |  |  | 0.032 |  | V |
| NON-LINEAR CONTROL |  |  |  |  |  |  |
|  | Offset of the non-linear control | Refer to Figure 23 |  | 20 |  | mV |
| OVER-TEMPERATURE PROTECTION |  |  |  |  |  |  |
| $\mathrm{T}_{\text {OTP }}$ | Over-Temperature Protection Trip Point |  |  | 160 |  | ${ }^{\circ} \mathrm{C}$ |
|  | OTP Release Threshold |  |  | 145 |  | ${ }^{\circ} \mathrm{C}$ |

NOTE:
7. Parameters with MIN and/or MAX limits are $100 \%$ tested at $+25^{\circ} \mathrm{C}$, unless otherwise specified. Temperature limits established by characterization and are not production tested

## Typical Performance Curves

Unless otherwise stated, all curves were tested with example circuit in Figure 1.


FIGURE 4. EFFICIENCY AT 12V INPUT, 1.5V OUTPUT


FIGURE 6. EFFICIENCY vs LOAD CURRENT AT 12V INPUT


FIGURE 8. LINE REGULATION, $\mathrm{V}_{\text {OUT }}=1.5 \mathrm{~V}, \mathrm{I}_{\mathrm{O}}=20 \mathrm{~A}$


FIGURE 5. EFFICIENCY AT 5V INPUT, 1.5V OUTPUT


FIGURE 7. EFFICIENCY vs LOAD CURRENT AT 5V INPUT


FIGURE 9. LOAD REGULATION, $\mathrm{V}_{\text {IN }}=12 \mathrm{~V}, \mathrm{~V}_{\text {OUT }}=1.5 \mathrm{~V}$

## Typical Performance Curves

Unless otherwise stated, all curves were tested with example circuit in Figure 1. (Continued)


FIGURE 10. FULL LOAD START-UP


FIGURE 12. HICCUP OCP


FIGURE 14. TRANSIENT RESPONSE 2A/ $\mu \mathrm{s}$


FIGURE 11. PRE-BIAS START-UP


FIGURE 13. TRANSIENT RESPONSE 2A/ $\mu \mathrm{s}$


FIGURE 15. CURRENT SHARING WITH 2-PHASE CONFIGURATION

## Typical Performance Curves

Unless otherwise stated, all curves were tested with example circuit in Figure 1. (Continued)


FIGURE 16. SHUTDOWN CURRENT vs TEMPERATURE


FIGURE 18. FEEDBACK VOLTAGE REFERENCE vs TEMPERATURE


FIGURE 20. FREQUENCY vs TEMPERATURE


FIGURE 17. OVERCURRENT THRESHOLD vs TEMPERATURE


FIGURE 19. DEAD TIME vs TEMPERATURE


FIGURE 21. FREQUENCY vs RFSET

## Functional Description

## Functional Overview

The ISL8115 is a synchronous buck PWM controller with current sharing capability. The current sharing function allows multiple modules to be connected in parallel to achieve higher output current. The controller also features multi-phase operation to reduce input and output ripple current, resulting in fewer components and reduced output dissipation.

Utilizing voltage-mode control with input voltage feed-forward compensation, the ISL8115 maintains a constant loop gain for optimal transient response, especially for applications with a wide input voltage range.

## Initialization

The ISL8115 requires $\mathrm{V}_{\mathrm{CC}}$ and PVCC biased by a single supply. The Power-On Reset (POR) function continually monitors the input supply voltages (PVCC and $\mathrm{V}_{\mathrm{CC}}$ ) and the voltage at EN pin.

With PVCC, $\mathrm{V}_{\mathrm{CC}}$ and EN above their POR thresholds, the IC will initialize a process to read the resistor value on the CONF and SS pins. This process can take up to 2 ms . Failure to read the resistor values will stop the soft-start process.

After successfully reading the resistor values on the CONF and SS pins, there is another 1 ms delay for the PLL.

If the system voltage drops below the falling POR threshold, then UGATE and LGATE are forced off. Also ISHARE is pulled low.

## Enable and Input Voltage UVLO

When the voltage on EN pin is greater than the 1.22 V threshold, the controller is enabled. If the EN voltage is less than 1.22 V minus the hysteresis (typical 65 mV ), the controller is disabled.

The EN pin can be used as a voltage monitor for the input undervoltage lock-out by connecting the EN pin to the input rail through a resistor divider.

## Pre-bias Startup

A pre-bias voltage may exist at the output before the controller is enabled. The ISL8115 can support a pre-bias startup condition by keeping UGATE and LGATE off until the internal soft-start voltage exceeds the feedback voltage. This feature prevents the output voltage from discharging through the lower MOSFET during the soft-start.

## Setting CONF Pin

A resistor connected from the CONF pin to ground is used to:

- Enable or disable diode emulation mode (DEM) after soft-start.
- Set the phase delay of CLKOUT with respect to an external clock signal applied to the FSET pin.

Use a resistor with 1\% tolerance on the CONF pin.
TABLE 1. RESISTOR VALUES TO SET CONF PIN

| PHASE DELAY $\left({ }^{\circ}\right)$ | DEM | 1\% TOLERANCE RESISTOR VALUE (k $\Omega$ ) |
| :---: | :---: | :---: |
| 0 | ENABLE | 46.4 |
| 60 |  | 73.2 |
| 90 |  | 105 |
| 120 |  | 137 |
| 180 |  | 11.8 |
| 240 |  | 18.2 |
| 270 |  | 26.1 |
| 300 |  | 34 |
| 0 | DISABLE <br> (Force CCM) | 2.94 |
| 60 |  | 4.53 |
| 90 |  | 6.49 |
| 120 |  | 8.66 |
| 180 |  | 0.732 |
| 240 |  | 1.13 |
| 270 |  | 1.62 |
| 300 |  | 2.15 |

## Setting SS pin

A resistor connected from the SS pin to ground is used to set the length of the output soft-start time. The internal soft-start DAC operates with and internal 2 MHz clock. The value of the resistor on this pin set number on steps for the soft-start. The resistor value and the corresponding soft-start duration is shown in Table 2. Use a resistor with $1 \%$ tolerance on the SS pin.
table 2. RESISTOR VALUES TO SET SOFT-START TIME

| 1\% TOLERANCE <br> RESISTOR VALUE <br> (k $)$ | SOFT-START TIME <br> $(\mathrm{ms})$ |
| :---: | :---: |
| 46.4 | 0.4 |
| 73.2 | 0.8 |
| 105 | 1.2 |
| 137 | 2.2 |
| 11.8 | 4.8 |
| 18.2 | 8.8 |
| 26.1 | 12.8 |
| 34 | 25.6 |

When using multiple ISL8115s in parallel module configuration, all soft-start times must be set to the same value.

## Frequency Setting

The switching frequency is set by the $\mathrm{R}_{\text {FSET }}$ connected between the FSET pin and ground. Figure 21 shows the typical R FSET $^{\text {vs }}$ Frequency variation curve. Equation 1 illustrates the relationship between $\mathrm{R}_{\text {FSET }}$ and switching frequency.

To synchronize with an external clock, apply a clock signal in the programmable oscillator range of 150 kHz to 1.5 MHz to the FSET pin. A duty cycle in the range of $10 \%$ to $90 \%$ is required.
$R_{\text {FSET }}=25 \times 10^{9} \cdot\left(\frac{1}{\text { Fsw }}-85 \times 10^{-9}\right)$

## Voltage Feed-forward

The voltage applied to the VFF pin can adjust the amplitude of the internal sawtooth ramp. It is recommended to set the amplitude equal to $\mathrm{V}_{\mathrm{FF}}$. This helps to maintain a constant gain contributed by the modulator and the input voltage to achieve optimum loop response over a wide input voltage range. Figure 22 shows the feed-forward circuits.


FIGURE 22. FEED-FORWARD CIRCUITRY
$\mathrm{V}_{\mathrm{FF}}$ voltage is clamped between 0.5 V (typical) and $\mathrm{V}_{\mathrm{Cc}}-2.2 \mathrm{~V}$ (typical). To make the feed forward work for all input voltage, the voltage on VFF pin should be designed within this range.

The peak-to-peak amplitude of the sawtooth yields as:
$V_{\text {ramp-pk-pk }}=I_{\text {discharge }} \times \frac{\mathrm{T}_{\mathrm{s}}-275 \mathrm{~ns}}{10 \mathrm{pF}}$
where:
$I_{\text {discharge }}=\frac{V_{F F}}{3 R_{\text {ramp }}}$
$\mathrm{T}_{\mathrm{s}}=\frac{1}{\mathrm{~F}_{\mathrm{sw}}}$
According to the Equations 2 and 3, design the resistor at the RAMP pin to make the amplitude of sawtooth equal to $\mathrm{V}_{\mathrm{FF}}$.
$R_{\text {ramp }}=\frac{T_{s}-275 n s}{3 \times 10 p F}$
For example, select $113 \mathrm{k} \Omega$ for $\mathrm{R}_{\text {FSET }}$ to achieve 220 kHz switching frequency and $140 \mathrm{k} \Omega$ for $R_{\text {ramp }}$ to make the $\mathrm{V}_{\text {ramp_pk_pk }}=\mathrm{V}_{\mathrm{FF}}$. The sawtooth ramp offset voltage is 1 V and the peak of the sawtooth is to $V_{F F}+1 V$.

## Non Linear Control

In order to respond faster to a load step, non-linear control has been introduced in ISL8115. If the feedback voltage at VMON is greater than the voltage of the previous cycle plus 20 mV (typical), the LG turns on immediately without waiting for the next clock signal. This function helps to improve the transient response especially for a controller with leading-edge modulator.


## Power-Good

The Power-Good comparator monitors the voltage on the VMON pin. The trip points are shown in Figure 24. Power-Good will not be asserted until the completion of the soft-start cycle. The Power-Good pulls low when EN is low or VMON is out of the threshold window. PGOOD stays high until the fault exists for three consecutive clock cycles.


FIGURE 24. PGOOD CIRCUIT

## Undervoltage and Overvoltage Protection

The Undervoltage (UV) and Overvoltage (OV) protection circuitry monitors the voltage on the VMON pin.

The UV functionality is not enabled until the end of soft-start. If the VMON drops below $50 \%$ of the 0.6 V internal reference, the controller goes into hiccup mode and recovers until VMON rises up to 0.332 V .

ISL8115 has 2 level OV thresholds: 115\% (non-latch), and 120\% (Latch). In an OV event with VMON between $115 \%$ and $120 \%$, the high-side MOSFET is turned off, while the low-side MOSFET turns on. At the same time PGOOD is also pulled down. When the VMON voltage drops to $85 \%$ of reference voltage, the LGATE is turned off, then hiccup restart occurs.
An OV event ( $\mathrm{V}_{\text {OUT }}>120 \%$ ) causes the high-side MOSFET to latch off permanently, while the low-side MOSFET turns on and then turns off after the output voltage drops below $85 \%$. At the same time, the PGOOD and ISHARE are also latched low. The latch condition can be reset only by re-cycling $\mathrm{V}_{\mathrm{CC}}$ or EN.

## POR Overvoltage Protection (POR-OVP)

When both the VCC and PVCC are below the POR thresholds, the UGATE is low and LGATE is floating (high impedance). EN has no control over LGATE when below POR. When above POR, the LGATE will toggle with its PWM pulses. An external 10k resistor can be placed between the PHASE and LGATE node to implement a PRE-POR-OVP circuit. The output of the converter is equal to the phase node voltage via output inductor and then is effectively clamped to the low-side MOSFET's gate threshold voltage, which provides some protection to the load if the upper MOSFET(s) is shorted during start-up, shutdown, or normal operations. For complete protection, the low-side MOSFET should have a gate threshold that is much smaller than the maximum voltage rating of the load.

The PRE-POR-OVP works against pre-biased start-up when pre-charged output voltage is higher than the threshold of the low-side MOSFET.

## Over-Temperature Protection (OTP)

When the junction temperature of the IC is greater than $+160^{\circ} \mathrm{C}$ (typically), the Ugate and Lgate are forced off. The ISHARE and PGOOD pins are forced low indicating a fault. In a multi-phase configuration, this pulls the ISHARE bus low and informs other channels to turn off. All connected ISHARE pins stay low, but release after the IC's junction temperature drops below the $+15^{\circ} \mathrm{C}$ hysteresis (typical). The device now starts the initialization process of reading the CONFIG and SS resistors, PLL locking, and soft-start.

## Inductor Current Sensing

The ISL8115 supports inductor DCR sensing techniques up to 5.5 V output voltage, as shown in Figure 25.


FIGURE 25. DCR SENSING CONFIGURATION
An inductor's winding is characteristic of a distributed resistance as measured by the DCR (Direct Current Resistance) parameter. Consider the inductor DCR as a separate lumped quantity, as shown in Figure 25. The inductor current, $\mathrm{I}_{\mathrm{L}}$, will also pass through the DCR. Equation 5 shows the S -domain equivalent voltage across the inductor $\mathrm{V}_{\mathrm{L}}$.
$V_{L}=I_{L} \cdot(s \cdot L+D C R)$
A simple R-C network across the inductor extracts the DCR voltage, as shown in Figure 25. The voltage on the capacitor $\mathrm{V}_{\mathrm{C}}$, can be shown to be proportional to the inductor current $\mathrm{I}_{\mathrm{L}}$, see Equation 6.
$V_{C}=\frac{\left(s \cdot \frac{L}{D C R}+1\right) \cdot\left(D C R \cdot I_{L}\right)}{(s \cdot R C+1)}$
If the R-C network components are selected such that the RC time constant ( $=\mathbf{R}^{*} \mathbf{C}$ ) matches the inductor time constant (= L/DCR), the voltage across the capacitor $\mathrm{V}_{\mathrm{C}}$ is equal to the voltage drop across the DCR, i.e., proportional to the inductor current. The value of $R$ should be as small as feasible for best signal-to-noise ratio. Make sure the resistor package size is appropriate for the power dissipated and include this loss in efficiency calculations.

In calculating the minimum value of R , the average voltage across $C$ (average of $I_{L} D C R$ product) is small and can be neglected. Therefore, the minimum value of $R$ may be approximated Equation 7:,

$$
\begin{equation*}
\mathrm{R}_{\min }=\frac{\mathrm{D} \cdot\left(\mathrm{~V}_{\mathrm{IN}-\mathrm{max}}-\mathrm{V}_{\mathrm{OUT}}\right)^{2}+(1-\mathrm{D}) \cdot \mathrm{V}_{\mathrm{OUT}}^{2}}{\mathrm{k} \cdot \mathrm{P}_{\mathrm{R}-\mathrm{pkg}} \cdot \delta_{\mathrm{P}}} \tag{EQ.7}
\end{equation*}
$$

where $P_{R-p k g}$ is the maximum power dissipation specification for the resistor package and $\delta_{P}$ is the derating factor for the same parameter (e.g., $P_{R-p k g}=0.063 \mathrm{~W}$ for 0402 package, $\delta_{P}=80 \%$ @ $+85^{\circ} \mathrm{C}$ ). k is the margin factor, also to limit temperature raise in the resistor package, recommend using 0.4. Once $R_{\text {min }}$ has been calculated, solve for the maximum value of C from Equation 8:
$C_{\text {max }}=\frac{L}{R_{\text {min }} \cdot D C R}$
Next, choose the next-lowest readily available value. Then substitute the chosen value into the same equation and re-calculate the value of R. Choose a $1 \%$ resistor standard value closest to this re-calculated value of $R$. For example, when $V_{I N}$ Max $=14.4 \mathrm{~V}, \mathrm{~V}_{\text {OUT }}=2.5 \mathrm{~V}, \mathrm{~L}=1 \mathrm{mH}$ and $\mathrm{DCR}=1.5 \mathrm{~m} \Omega$, with 0402 package Equation 7 yields $\mathrm{R}_{\text {min }}$ of $1476 \Omega$ and Equation 8 yields $\mathrm{C}_{\text {max }}$ of $0.45 \mu \mathrm{~F}$. Choose $0.39 \mu \mathrm{~F}$ and re-calculate, the resistor yields $1.69 \mathrm{k} \Omega$.

With the internal low-offset current amplifier, the capacitor voltage Vc is replicated across the sense resistor $\mathrm{R}_{\text {ISEN }}$. Therefore, the current out of ISENB pin, ISEN, is proportional to the inductor current.

## Peak Current Limit

The ISL8115 contains a peak current limit circuit to protect the converter.

When a peak current limit occurs, the UG is turned off immediately. An internal counter begins to record the number of OC events detected. Two consecutive clock cycles without a current limit will reset the counter. If 8 consecutive clock cycles of overcurrent is detected, the ISL8115 enters into a hiccup mode. The ISL8115 operation during the peak current limit event is illustrated in Figure 26.

The sensed current signal and peak current signal in Figure 25 can be derived by the following equations:
$\mathrm{I}_{\text {SEN }}=\frac{\mathrm{I}_{\mathrm{L}} \cdot \text { DCR }}{\mathrm{R}_{\text {ISEN }}}$
$I_{S E N-P K}=\frac{\left(I_{L}+\frac{V_{\text {out }}}{L} \cdot \frac{1-D}{2 F_{\text {SW }}}\right) \cdot D C R}{R_{\text {ISEN }}}$


FIGURE 26. CURRENT LIMIT TIMING

## Average Overcurrent Protection

The ISL8115 provides an average overcurrent protection circuit to protect the converter during an overcurrent fault.

The voltage on pin ISET represents the average inductor current signal which compares with an internal reference of 1.4 V to implement positive overcurrent protection and 0.25 V for negative current protection. If the overcurrent event is detected, the ISL8115 will enter hiccup mode. This consists of a 10 ms shut down and then a restart. The voltage on pin ISET can be obtained from Equation 11. The circuit of average OCP is shown in Figure 27.
$\mathrm{V}_{\text {ISET }}=\left(5 \mathrm{I}_{\text {SEN }}+50 \mu \mathrm{~A}\right) \cdot \mathrm{R}_{\text {ISET }}$


FIGURE 27. AVERAGE OCP CIRCUIT
Select a suitable $\mathrm{R}_{\text {ISET }}$ for setting the OCP trigger point. Also, a filer capacitor $\mathrm{C}_{\text {ISET }}$ is required in parallel with $\mathrm{R}_{\text {ISET }}$ to get the average inductor current signal.

Generally, set the average OCP trigger point lower than the peak current limit.

For example, $\mathrm{L}=2.5 \mu \mathrm{H}$; DCR $=1.6 \mathrm{~m} \Omega$; $\mathrm{I}_{\mathrm{OUT}}=20 \mathrm{~A} ; \mathrm{di}=8 \mathrm{~A}$; $\mathrm{F}_{\text {SW }}=220 \mathrm{kHz}$. To set 24A as the output peak current limit. RSEN can be derived by:
$R_{\text {SEN }}=\frac{\left(\mathrm{I}_{\mathrm{OC}}+\frac{1}{2} \mathrm{di}\right) \cdot \mathrm{DCR}}{20 \mathrm{uA}}=\frac{(24 \mathrm{~A}+4 \mathrm{~A}) \times 1.6 \mathrm{~m} \Omega}{20 \mathrm{uA}}=2.24 \mathrm{k} \Omega$
Considering DCR increases as the temperature rises. Select $3 \mathrm{k} \Omega$ ( $2.24 \mathrm{k} \Omega \times 1.34$ ) for $\mathrm{R}_{\text {SEN }}$.
To set 22A for the average OCP, the value of $\mathrm{R}_{\text {ISET }}$ can be yield as:
$\mathrm{R}_{\text {ISET }}=\frac{1.4 \mathrm{~V}}{\frac{22 \mathrm{~A} \times 1.34 \mathrm{DCR}}{3 \mathrm{k} \Omega} \times 5+50 \mathrm{uA}}=10.7 \mathrm{k} \Omega$
To filter the inductor ripple current and achieve the average inductor current signal from ISET, the roll off frequency of the low pass filter should be much lower than the switching frequency. Capacitor at ISET CISET is obtained by Equation 14:
$\frac{1}{2 \pi R_{\text {ISET }} \cdot \mathrm{C}_{\text {ISET }}}<\frac{1}{10} \cdot \mathrm{~F}_{\text {SW }}$
$C_{\text {ISET }}>\frac{10}{F_{\text {SW }}} \cdot \frac{1}{2 \pi R_{\text {ISET }}}=0.68 \mathrm{nF}$

## DEM

Diode emulation allows for higher converter efficiency under light load situations. With diode emulation active, the ISL8115 will detect the zero current crossing of the output inductor and turn off LGATE. This ensures that discontinuous conduction mode (DCM) is achieved. This prevents the low side MOSFET from sinking current and discharging of the output during pre-biased startup. DEM can only be disabled after soft-start. Please refer to the "Electrical Specifications" table on page 10 for the threshold of DEM.

## Current Sharing

The ISL8115 can support up to 6 phase operation. Connecting the ISHARE pins together allows for communication between the phases. In a single phase application, the voltage on the ISHARE pin follows the ISET voltage and the ISHARE pin can be floated. However, in multi-phase applications, the voltage on the ISHARE bus represents the highest ISET voltage of all phases. This voltage becomes the current reference of each phase. Figure 28 illustrates the relation between ISHARE and ISET.


FIGURE 28. CURRENT SENSING BLOCK DIAGRAM
The voltage difference between ISHARE and ISET will create two correction currents (See Figure 29). One is Ish_corr1 which makes the COMP voltage increase and the other is Ish_corr2 which makes the RGND voltage increase. A resistor (typically $100 \Omega$ ) connected between RGND and the output capacitor ground is required. The correction currents make the duty cycle increase thereby making the voltage at ISET track the voltage at ISHARE within 10 mV of offset.


Select a 1 nF Capacitor for $\mathrm{C}_{\text {ISET }}$.


FIGURE 30. SIMPLIFIED MULTI-PHASE DIAGRAM
Figure 30 shows 3 -phase operation. Device 1 is the master and the remaining devices are synchronized and phase shifted. The phase shift can be set using the CONF pin.

The ISHARE bus remains low until the PLL of all phases are locked. This assures that all phases start up at the same time, thereby preventing an overcurrent condition. A $40 \mathrm{k} \Omega$ resistor is required between the ISHARE bus and ground.

## Feedback Compensation

Figure 31 highlights the voltage-mode control loop for a synchronous-rectified buck converter. The output voltage ( $\mathrm{V}_{\mathrm{OUT}}$ ) is regulated to the reference voltage level. The error amplifier output ( $\mathrm{V}_{\mathrm{EA}}$ ) is compared with the oscillator (OSC) sawtooth waveform to provide a pulse-width modulated (PWM) signal with an amplitude of VIN at the PHASE node. The PWM signal is smoothed by the output filter ( $\mathrm{L}_{\mathrm{O}}$ and $\mathrm{C}_{0}$ ).
This function is dominated by a DC Gain and the output filter ( $L_{0}$ and $C_{0}$ ), with a double pole break frequency at $F_{L C}$ and a zero at $F_{\text {ESR }}$. The DC Gain of the modulator is simply the input voltage $\left(\mathrm{V}_{\text {IN }}\right)$ divided by the peak-to-peak oscillator voltage $\Delta \mathrm{V}_{\text {OSC }}$.


FIGURE 31. VOLTAGE- MODE BUCK CONVERTER COMPENSATION DESIGN

## Modulator Break Frequency Equations

$F_{L C}=\frac{1}{2 \pi \cdot \sqrt{L_{O} \cdot C_{O}}}$
$\mathrm{F}_{\mathrm{ESR}}=\frac{1}{2 \pi \cdot\left(\mathrm{ESR} \cdot \mathrm{C}_{\mathrm{O}}\right)}$

The compensation network consists of the error amplifier (internal to the ISL8115) and the impedance networks $\mathrm{Z}_{\mathrm{IN}}$ and $\mathrm{Z}_{\mathrm{FB}}$. The goal of the compensation network is to provide a closed loop transfer function with the highest OdB crossing frequency ( $\mathrm{f}_{0 \mathrm{~dB}}$ ) and adequate phase margin. Phase margin is the difference between the closed loop phase at $f_{0 d B}$ and $180^{\circ}$. The following equations relate to the compensation network's poles, zeros and gain to the components ( $\mathrm{R}_{1}, \mathrm{R}_{2}, \mathrm{R}_{3}, \mathrm{C}_{1}, \mathrm{C}_{2}$, and $\mathrm{C}_{3}$ ) in Figure 31. Use the following guidelines for locating the poles and zeros of the compensation network.

## Compensation Break Frequency Equations

$F_{Z 1}=\frac{1}{2 \pi \cdot R 2 \cdot C 1}$
$\mathrm{F}_{\mathrm{P} 1}=\frac{1}{2 \pi \cdot \mathrm{R} 2 \cdot\left(\frac{\mathrm{C} 1 \cdot \mathrm{C} 2}{\mathrm{C} 1+\mathrm{C} 2}\right)}$
$\mathrm{F}_{\mathrm{Z} 2}=\frac{1}{2 \pi \cdot(\mathrm{R} 1+\mathrm{R} 3) \cdot \mathrm{C} 3}$
$\mathrm{F}_{\mathrm{P} 2}=\frac{1}{2 \pi \bullet \mathrm{R} 3 \cdot \mathrm{C} 3}$

1. Pick Gain (R2/R1) for desired converter bandwidth
2. Place $1^{\text {ST }}$ Zero Below Filter's Double Pole ( $\sim 75 \%$ FLC $)$
3. Place $2^{N D}$ Zero at Filter's Double Pole
4. Place $1^{\text {ST }}$ Pole at the ESR Zero
5. Place $2^{N D}$ Pole at Half the Switching Frequency
6. Check Gain against Error Amplifier's Open-Loop Gain
7. Estimate Phase Margin - Repeat if Necessary

Figure 32 shows an asymptotic plot of the DC/DC converter's gain vs frequency. The actual Modulator Gain has a high gain peak due to the high Q factor of the output filter and is not shown in Figure 32. Using the previously mentioned guidelines should give a compensation gain similar to the curve plotted. The open loop error amplifier gain bounds the compensation gain. Check the compensation gain at $\mathrm{F}_{\mathrm{P} 2}$ with the capabilities of the error amplifier. The Loop Gain is constructed on the log-log graph of Figure 32 by adding the Modulator Gain (in dB) to the Compensation Gain (in dB). This is equivalent to multiplying the modulator transfer function to the compensation transfer function and plotting the gain.


FIGURE 32. ASYMPTOTIC BODE PLOT OF CONVERTER GAIN
The compensation gain uses external impedance networks $Z_{F B}$ and $Z_{\text {IN }}$ to provide a stable, high bandwidth (BW) overall loop. A stable control loop has a gain crossing with $-20 \mathrm{~dB} /$ decade slope and a phase margin greater than $45^{\circ}$. Include worst case component variations when determining phase margin.

Component Selection Guidelines

## OUTPUT CAPACITOR SELECTION

The output capacitors should be selected to meet the dynamic regulation requirements including ripple voltage and load transients. Selection of output capacitors is also dependent on the output inductor, thus some inductor analysis is required to select the output capacitors.

One of the parameters limiting the converter's response to a load transient is the time required for the inductor current to slew to its new level. The response time is the time interval required to slew the inductor current from an initial current value to the load current level. During this interval the difference between the inductor current and the transient current level must be supplied by the output capacitor(s). Minimizing the response time can minimize the output capacitance required. Also, if the load transient rise time is slower than the inductor response time, as in a hard drive or CD drive, it reduces the requirement on the output capacitor.
The maximum capacitor value required to provide the full, rising step, transient load current during the response time of the inductor is shown in Equation 21:
$C_{\text {OUT }}=\frac{\left(\mathrm{L}_{\mathrm{O}}\right)\left(\mathrm{I}_{\text {TRAN }}\right)^{2}}{2\left(\mathrm{~V}_{\text {IN }}-\mathrm{V}_{\mathrm{O}}\right)\left(\mathrm{DV}_{\mathrm{OUT}}\right)}$
where $\mathrm{C}_{\mathrm{OUT}}$ is the output capacitor(s) required, $\mathrm{L}_{\mathrm{O}}$ is the output inductor, $\mathrm{I}_{\text {TRAN }}$ is the transient load current step, $\mathrm{V}_{\text {IN }}$ is the input voltage, $\mathrm{V}_{\mathrm{O}}$ is output voltage, and $\mathrm{DV}_{\mathrm{OUT}}$ is the drop in output voltage allowed during the load transient.

High frequency capacitors initially supply the transient current and slow the load rate-of-change seen by the bulk capacitors. The bulk filter capacitor values are generally determined by the ESR (Equivalent Series Resistance) and voltage rating requirements as well as actual capacitance requirements.

The output voltage ripple is due to the inductor ripple current and the ESR of the output capacitors as defined by Equation 22:
$\mathrm{V}_{\text {RIPPLE }}=\Delta \mathrm{I}_{\mathrm{L}}(E S R)$
High frequency decoupling capacitors should be placed as close to the power pins of the load as physically possible. Be careful not to add inductance in the circuit board wiring that could cancel the usefulness of these low inductance components. Consult with the manufacturer of the load circuitry for specific decoupling requirements.

Use only specialized low-ESR capacitors intended for switching-regulator applications for the bulk capacitors. In most cases, multiple small-case electrolytic capacitors perform better than a single large-case capacitor.

## OUTPUT INDUCTOR SELECTION

The output inductor is selected to meet the output voltage ripple requirements and minimize the converter's response time to the load transient. The inductor value determines the converter's ripple current and the ripple voltage is a function of the ripple current and output capacitor(s) ESR. The ripple current is approximated by Equation 23:
$\Delta \mathrm{I}_{\mathrm{L}}=\frac{\left(\mathrm{V}_{\mathrm{IN}}-\mathrm{V}_{\mathrm{OUT}}\right)\left(\mathrm{V}_{\mathrm{OUT}}\right)}{\left(\mathrm{f}_{\mathrm{S}}\right)\left(\mathrm{L}_{\mathrm{O}}\right)\left(\mathrm{V}_{\mathrm{IN}}\right)}$
Increasing the value of inductance reduces the ripple current and voltage. However, the large inductance values reduce the converter's response time to a load transient. Also, it always means more expensive and large size.

## INPUT CAPACITOR SELECTION

The important parameters for the bulk input capacitor(s) are the voltage rating and the RMS current rating. For reliable operation, select bulk input capacitors with voltage and current ratings above the maximum input voltage and largest RMS current required by the circuit. The capacitor voltage rating should be at least $1.25 x$ greater than the maximum input voltage and $1.5 x$ is a conservative guideline. The AC RMS Input current varies with the load. The total RMS current supplied by the input capacitance is given by Equation 24:
$I_{R M S x}=\sqrt{I_{O}^{2}\left(D-D^{2}\right)+\frac{\Delta I_{L}^{2}}{12} D}$
where, $D$ is duty cycle of the buck converter.
Use a mix of input bypass capacitors to control the voltage ripple across the MOSFETs. Use ceramic capacitors for the high frequency decoupling and bulk capacitors to supply the RMS current. Small ceramic capacitors can be placed very close to the upper MOSFET to suppress the voltage induced in the parasitic circuit impedances.

## MOSFET SELECTION

The logic level MOSFETs are chosen for optimum efficiency given the potentially wide input voltage range and output power requirements, two N-Channel MOSFETs for the Buck converter. These MOSFETs should be selected based upon $r_{\text {DS(ON) }}$, gate supply requirements, and thermal management considerations.

Compared with other components, MOSFETs contribute significant power loss to the converter. Power loss of high side FET includes switching losses, conduction losses and gate charge losses. Low side FET contributes conduction losses and gate charge losses too, also reverse recovery loss and loss of the body diode during dead time should be considered.

Power loss of high side MOSFET can be expressed as:
$P_{H}=\left(I_{o}^{2}+\frac{\Delta I_{L}^{2}}{12}\right) \cdot D \cdot R_{D S(o n)}+V_{I N} I_{o} t_{s w} F_{s w}+V_{I N} Q_{H} F_{s w}$
where $t_{s w}$ is switching interval includes on and off intervals. $Q_{H}$ is gate charge of the high side MOSFET.
Power loss of low side MOSFET derived as:
$P_{L}=\left(I_{o}^{2}+\frac{\Delta I_{L}^{2}}{12}\right) \cdot(1-D) \cdot R_{D S(o n)}+V_{I N} Q_{r r} F_{s w}+V_{I N} Q_{L} F_{s w}$
where $Q_{r r}$ is the total reverse recovery charge. $Q_{L}$ is gate charge of the low side MOSFET.

## Layout Considerations

As in any high frequency switching converter, layout is very important. Switching current from one power device to another can generate voltage transients across the impedances of the interconnecting bond wires and circuit traces. These interconnecting impedances should be minimized by using wide, short printed circuit traces. The critical components should be located as close together as possible using ground plane construction or single point grounding.
Figure 33 shows the critical power components of the buck converter. To minimize the voltage overshoot the interconnecting wires indicated by heavy lines should be part of ground or power plane in a printed circuit board. The components shown in Figure 33 should be located as close together as possible. Please note that the capacitors $C_{I N}$ and $C_{O}$ each represent numerous physical capacitors. Locate the ISL8115 within 3 inches of the MOSFETs, $\mathrm{Q}_{1}$ and $\mathrm{Q}_{2}$. The circuit traces for the MOSFETs' gate and source connections from the ISL8115 must be sized to handle up to 4A peak current.


FIGURE 33. CRITICAL POWER TRAIN LOOP
Figure 34 shows the current sensing loop of the ISL8115 which is a sensitive analog loop needs "quiet and clean environment". To minimize the coupling from switching nodes, using differential pair as the sensing route. R should be located close to the inductor; C and RISEN should be close to the IC.


FIGURE 34. CURRENT SENSING LOOP

## General PowerPAD Design Considerations

Figure 35 is an example of how to use vias to remove heat from the IC.


We recommend you fill the thermal pad area with vias. A typical via array would be to fill the thermal pad footprint with space, such that they are center on center $3 x$ the radius apart from each other. Keep the Vias small but not so small that their inside diameter prevents solder wicking through the holes during reflow.

Connect all vias to the ground plane. It is important the vias have a low thermal resistance for efficient heat transfer. It is important to have a complete connection of the plated through-hole to each plane.

## Revision History

The revision history provided is for informational purposes only and is believed to be accurate, but not warranted. Please go to web to make sure you have the latest revision.

| DATE | REVISION |  |
| :---: | :---: | :--- |
| September 23, 2013 | FN8272.1 | Initial Release. |

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## Package Outline Drawing

## L24.4X4F

## 24 LEAD THIN QUAD FLAT NO-LEAD PLASTIC PACKAGE

Rev 2, 1/11

$\underline{\underline{\text { TOP VIEW }}}$


$\underline{\underline{\text { TYPICAL RECOMMENDED LAND PATTERN }}}$


NOTES:

1. Dimensions are in millimeters.

Dimensions in ( ) for Reference Only.
2. Dimensioning and tolerancing conform to ASME Y14.5m-1994.

Unless otherwise specified, tolerance : Decimal $\pm 0.05$
4. Dimension applies to the metallized terminal and is measured between 0.15 mm and 0.30 mm from the terminal tip.
5. Tiebar shown (if present) is a non-functional feature.
6. The configuration of the pin \#1 identifier is optional, but must be located within the zone indicated. The pin \#1 identifier may be either a mold or mark feature.
7. Compliant to JEDEC MO-220 VGGD-8.

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NCP1246BLD065R2G NTE7154 NTE7242 LTC7852IUFD-1\#PBF LTC7852EUFD-1\#PBF MB39A136PFT-G-BND-ERE1
NCP1256BSN100T1G LV5768V-A-TLM-E NCP1365BABCYDR2G NCP1365AABCYDR2G MCP1633T-E/MG MCP1633-E/MG
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